Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/073,599	DAIGO ET AL.	
Examiner	Art Unit	
LUONG T. NGUYEN	2622	

SEARCHED			
Class	Subclass	Date	Examiner
			_
			·
			-

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
725/105; 348/231.99,231.3,231.6, 207.1,207.99,552 (text search only, see search history printout)	3/4/2006	LN
EAST (USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB) see search history printout	3/4/2006	LN
updated East using previously cited references	10/12/2006	LN
		·